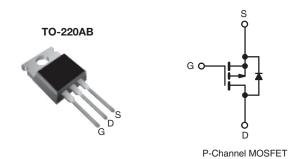


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 50			
R _{DS(on)} (Ω)	V _{GS} = - 10 V	0.28		
Q _g (Max.) (nC)	26			
Q _{gs} (nC)	6.2			
Q _{gd} (nC)	8.6			
Configuration	Single			



FEATURES

- P-Channel Versatility
- Compact Plastic Package
- · Fast Switching
- Low Drive Current
- Ease of Paralleling
- Excellent Temperature Stability
- Compliant to RoHS Directive 2002/95/EC



COMPLIANT

DESCRIPTION

The Power MOSFET technology is the key to Vishay's advanced line of Power MOSFET transistors. The efficient geometry and unique processing of the Power MOSFET design achieve very low on-state resistance combined with high transconductance and extreme device ruggedness.

The P-channel Power MOSFET's are designed for application which require the convenience of reverse polarity operation. They retain all of the features of the more common N-channel Power MOSFET's such as voltage control, very fast switching, ease of paralleling, and excellent temperature stability.

P-channel Power MOSFETs are intended for use in power stages where complementary symmetry with N-channel devices offers circuit simplification. They are also very useful in drive stages because of the circuit versatility offered by the reverse polarity connection. Applications include motor control, audio amplifiers, switched mode converters, control circuits and pulse amplifiers.

ORDERING INFORMATION	
Package	TO-220AB
Load (Dh) froe	IRF9Z20PbF
Lead (Pb)-free	SiHF9Z20-E3
SnPb	IRF9Z20
SIFD	SiHF9Z20

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	- 50		
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	\/ at 10\/	T _C = 25 °C	_	- 9.7		
	V_{GS} at - 10 V $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 100 ^{\circ}\text{C}$	I _D	- 6.1	Α		
Pulsed Drain Current ^a			I _{DM}	- 39		
Linear Derating Factor				0.32	W/°C	
Inductive Current, Clamped	L = 100 μH		I _{LM}	- 39	Α	
Unclamped Inductive Current (Avalanche Current)			ΙL	- 2.2	Α	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	40	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature)	for 10 s			300°		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L =100 μ H, R_q = 25 Ω
- c. 0.063" (1.6 mm) from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	80		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	1.0	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.1		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V_{DS}	V _{GS} = 0 V, I _D = - 250 μA		- 50	-	-	V
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$		-	- 4.0	٧
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V		-	± 500	nA
Zero Gate Voltage Drain Current	l	$V_{DS} = m$	V _{DS} = max. rating, V _{GS} = 0 V		-	- 250	μA
Zero Gate Voltage Drain Gurrent	I _{DSS}	V _{DS} = max. rati	ng x 0,8, V _{GS} = 0 V, T _J =125°C	-	-	- 1000	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 5.6 A ^b	1	0.20	0.28	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 2	$x V_{GS}$, $I_{DS} = -5.6 A^b$	2.3	3.5	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$ f = 1.0 MHz, see fig. 9		1	480	-	pF
Output Capacitance	C_{oss}			i	320	-	
Reverse Transfer Capacitance	C_{rss}			1	58	-	
Total Gate Charge	Q_g	V _{GS} = - 10 V		-	17	26	
Gate-Source Charge	Q_{gs}		-	4.1	6.2	nC	
Gate-Drain Charge	Q_{gd}		max. rating. see fig. 17	-	5.7	8.6	1
Turn-On Delay Time	t _{d(on)}	V_{DD} = - 25 V, I_D = - 9.7 A, R_g = 18 Ω , R_D = 2.4 Ω , see fig. 16 (MOSFET switching times are essentially independent of operating temperature)		-	8.2	12	ns
Rise Time	t _r			-	57	86	
Turn-Off Delay Time	t _{d(off)}			-	12	18	
Fall Time	t _f			-	25	38	
Internal Drain Inductance	L _D	6 mm (0.25'	Between lead, 6 mm (0.25") from		4.5	-	- nH
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	
Drain-Source Body Diode Characteristics	3						
Continuous Source-Drain Diode Current	Is	,	MOSFET symbol showing the		-	- 9.7	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	- 39	A
Body Diode Voltage	V _{SD}	T _J = 25 °C	, I _S = - 9.7 A, V _{GS} = 0 V ^b	-	-	- 6.3	V
Body Diode Reverse Recovery Time	t _{rr}	T 05.00 !			110	280	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = -9.7 \text{A}, dl/dt = 100 \text{A/} \mu \text{s}^{\text{b}}$		0.17	0.34	0.85	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and I				d L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

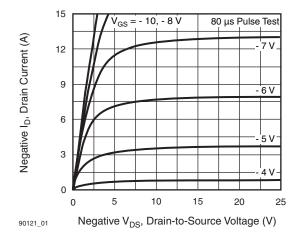


Fig. 1 - Typical Output Characteristics

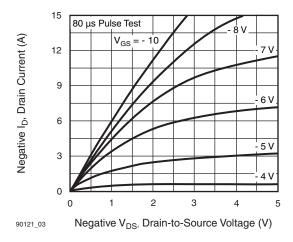


Fig. 3 - Typical Saturation Characteristics

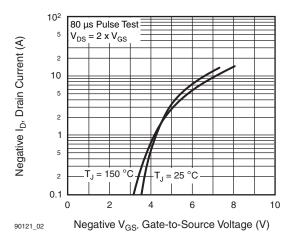


Fig. 2 - Typical Transfer Characteristics

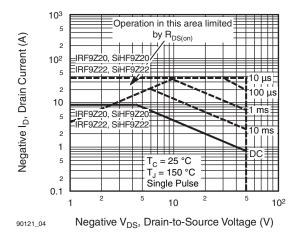


Fig. 4 - Maximum Safe Operating Area



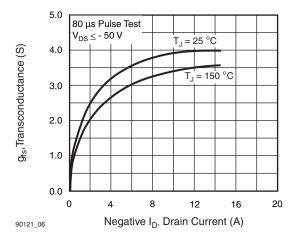


Fig. 5 - Typical Transconductance vs. Drain Current

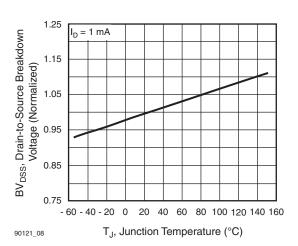


Fig. 7 - Breakdown Voltage vs. Temperature

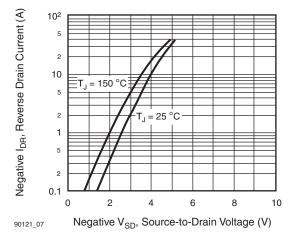


Fig. 6 - Typical Source-Drain Diode Forward Voltage

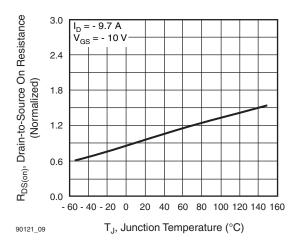
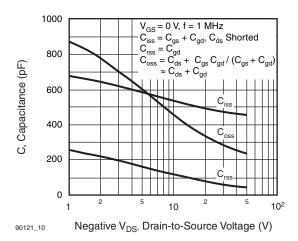


Fig. 8 - Normalized On-Resistance vs. Temperature





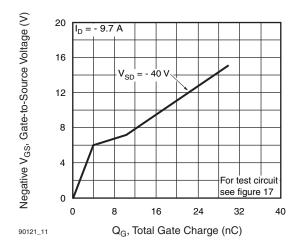


R_{DS(on)}, Drain-to-Source On Resistance 1.6 1.2 $V_{GS} = -10 \text{ V}$ 0.8 0.4 0.0 0 8 16 32 40 Negative I_D, Drain Current (A) 90121_12

80 μs Pulse Test

Fig. 9 - Typical Capacitance vs. Drain-to-Source Voltage

Fig. 11 - Typical On-Resistance vs. Drain Current



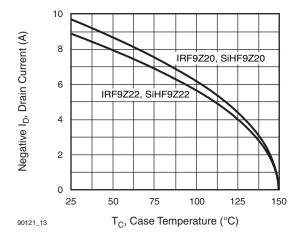
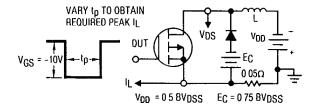


Fig. 10 - Typical Gate Charge vs. Gate-to-Source Voltage

Fig. 12 - Maximum Drain Current vs. Case Temperature





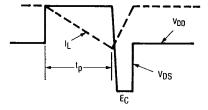


Fig. 13a - Unclamped Inductive Test Circuit

Fig. 13b - Unclamped Inductive Load Test Waveforms

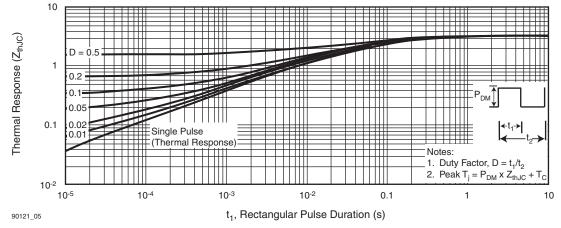


Fig. 14 - Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration

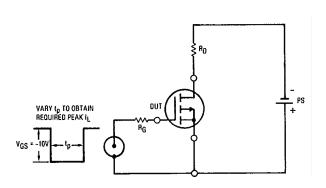


Fig. 15 - Switching Time Test Circuit

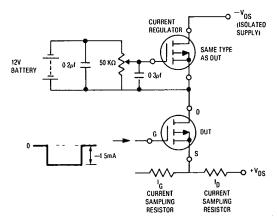
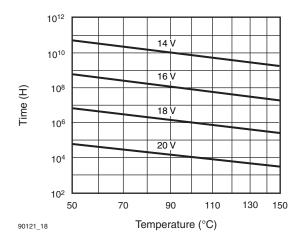


Fig. 16 - Gate Charge Test Circuit





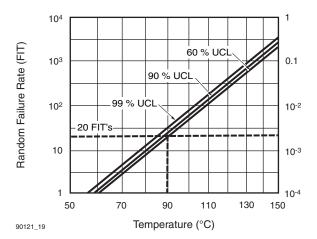


Fig. 17 - Typical Time to Accumulated 1 % Gate Failure

Fig. 18 - Typical High Temperature Reverse Bias (HTRB) Failure Rate

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